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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	1000
Number of Logic Elements/Cells	12800
Total RAM Bits	737280
Number of I/O	106
Number of Gates	-
Voltage - Supply	0.95V ~ 1.05V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	238-LFBGA, CSPBGA
Supplier Device Package	238-CSBGA (10x10)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7a12t-l1cpq236i">https://www.e-xfl.com/product-detail/xilinx/xc7a12t-l1cpq236i</a>

Table 2: Recommended Operating Conditions<sup>(1)(2)</sup> (Cont'd)

Symbol	Description	Min	Typ	Max	Units
<b>Temperature</b>					
$T_j$	Junction temperature operating range for commercial (C) temperature devices	0	—	85	°C
	Junction temperature operating range for extended (E) temperature devices	0	—	100	°C
	Junction temperature operating range for industrial (I) temperature devices	-40	—	100	°C

**Notes:**

1. All voltages are relative to ground.
2. For the design of the power distribution system consult [UG483, 7 Series FPGAs PCB Design and Pin Planning Guide](#).
3. Configuration data is retained even if  $V_{CCO}$  drops to 0V.
4. Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
5. The lower absolute voltage specification always applies.
6. A total of 200 mA per bank should not be exceeded.
7.  $V_{CCBATT}$  is required only when using bitstream encryption. If battery is not used, connect  $V_{CCBATT}$  to either ground or  $V_{CCAUX}$ .
8. Each voltage listed requires the filter circuit described in [UG482: 7 Series FPGAs GTP Transceiver User Guide](#).
9. Voltages are specified for the temperature range of  $T_j = 0^\circ\text{C}$  to  $+85^\circ\text{C}$ .

Table 3: DC Characteristics Over Recommended Operating Conditions

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
$V_{DRINT}$	Data retention $V_{CCINT}$ voltage (below which configuration data might be lost)	0.75	—	—	V
$V_{DRI}$	Data retention $V_{CCAUX}$ voltage (below which configuration data might be lost)	1.5	—	—	V
$I_{REF}$	$V_{REF}$ leakage current per pin	—	—	15	μA
$I_L$	Input or output leakage current per pin (sample-tested)	—	—	15	μA
$C_{IN}^{(2)}$	Die input capacitance at the pad	—	—	8	pF
$I_{RPU}$	Pad pull-up (when selected) @ $V_{IN} = 0\text{V}$ , $V_{CCO} = 3.3\text{V}$	90	—	330	μA
	Pad pull-up (when selected) @ $V_{IN} = 0\text{V}$ , $V_{CCO} = 2.5\text{V}$	68	—	250	μA
	Pad pull-up (when selected) @ $V_{IN} = 0\text{V}$ , $V_{CCO} = 1.8\text{V}$	34	—	220	μA
	Pad pull-up (when selected) @ $V_{IN} = 0\text{V}$ , $V_{CCO} = 1.5\text{V}$	23	—	150	μA
	Pad pull-up (when selected) @ $V_{IN} = 0\text{V}$ , $V_{CCO} = 1.2\text{V}$	12	—	120	μA
$I_{RPD}$	Pad pull-down (when selected) @ $V_{IN} = 3.3\text{V}$	68	—	330	μA
	Pad pull-down (when selected) @ $V_{IN} = 1.8\text{V}$	45	—	180	μA
$I_{CCADC}$	Analog supply current, analog circuits in powered up state	—	—	25	mA
$I_{BATT}^{(3)}$	Battery supply current	—	—	150	nA
$R_{IN\_TERM}^{(4)}$	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_40) for commercial (C), and industrial (I), and extended (E) temperature devices	28	40	55	Ω
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_50) for commercial (C), and industrial (I), and extended (E) temperature devices	35	50	65	Ω
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_60) for commercial (C), and industrial (I), and extended (E) temperature devices	44	60	83	Ω

**Table 6** shows the minimum current, in addition to  $I_{CCQ}$ , that is required by Artix-7 devices for proper power-on and configuration. If the current minimums shown in **Table 5** and **Table 6** are met, the device powers on after all four supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the Xilinx Power Estimator (XPE) tools to estimate current drain on these supplies.

**Table 6: Power-On Current for Artix-7 Devices<sup>(1)</sup>**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCBRAMMIN}$	Units
	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	
XC7A100T	$I_{CCINTQ} + 170$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 60$	mA
XC7A200T	$I_{CCINTQ} + 340$	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 80$	mA

**Notes:**

1. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.
2. Typical values are specified at nominal voltage, 25°C.

**Table 7: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625V$	$T_J = 100^{\circ}\text{C}^{(1)}$	—	500	ms
		$T_J = 85^{\circ}\text{C}^{(1)}$	—	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms

**Notes:**

1. Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with worst case  $V_{CCO}$  of 3.465V.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 8: SelectIO DC Input and Output Levels<sup>(1)(2)</sup>

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA, Max	mA, Min
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8.00	-8.00
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8.00	-8.00
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16.00	-16.00
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16.00	-16.00
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.10	-0.10
LVCMOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVCMOS15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVCMOS18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVCMOS25	-0.300	0.7	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 4	Note 4
LVCMOS33	-0.300	0.8	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 4	Note 4
LVTTL	-0.300	0.8	2.000	3.450	0.400	2.400	Note 5	Note 5
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.10	-0.10
PCI33_3	-0.500	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.50	-0.50
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.00	-13.00
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.90	-8.90
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.00	-13.00
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.90	-8.90
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8.00	-8.00
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.40	-13.40

**Notes:**

- Tested according to relevant specifications.
- 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
- Supported drive strengths of 4, 8, or 12 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, or 16 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, 16, or 24 mA in HR I/O banks.
- For detailed interface specific DC voltage levels, see [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).

Table 9: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	—	—	—	1.250	—	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> –0.405	V <sub>CCO</sub> –0.300	V <sub>CCO</sub> –0.190	0.400	0.600	0.800

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.

Table 10: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>		V <sub>OL</sub> <sup>(3)</sup>		V <sub>OH</sub> <sup>(4)</sup>		I <sub>OL</sub>	I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min		
DIFF_HSTL_I	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	–8.00		
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	–8.00		
DIFF_HSTL_II	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	–16.00		
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	–16.00		
DIFF_HSUL_12	0.300	0.600	0.850	0.100	—	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	–0.100		
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	—	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	–0.100		
DIFF_SSTL135	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	–13.0		
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	–8.9		
DIFF_SSTL15	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	–13.0		
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	–8.9		
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	–8.00		
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	–13.4		

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## Speed Grade Designations

Since individual family members are produced at different times, the migration from one category to another depends completely on the status of the fabrication process for each device. [Table 12](#) correlates the current status of each Artix-7 device on a per speed grade basis.

[Table 12: Artix-7 Device Speed Grade Designations](#)

Device	Speed Grade Designations		
	Advance	Preliminary	Production
XC7A100T	-2L (0.9V)		-3, -2, -2L (1.0V), -1
XC7A200T	-2L (0.9V)		-3, -2, -2L (1.0V), -1

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

[Table 13](#) lists the production released Artix-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

[Table 13: Artix-7 Device Production Software and Speed Specification Release](#)

Device	Speed Grade			
	1.0V			0.9V
	-3	-2/-2L	-1	-2L
XC7A100T	ISE 14.4 and Vivado 2012.4 with the 14.4/2012.4 device pack v1.07			
XC7A200T	ISE 14.4 and Vivado 2012.4 with the 14.4/2012.4 device pack v1.07			

**Notes:**

- Blank entries indicate a device and/or speed grade in advance or preliminary status.

## Input/Output Logic Switching Characteristics

Table 18: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>ICE1CK/T<sub>ICKCE1</sub></sub>	CE1 pin setup/hold with respect to CLK	0.48/0.02	0.54/0.02	0.76/0.02	0.40/-0.07	ns
T <sub>ISRCK/T<sub>ICKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.60/0.01	0.70/0.01	1.13/0.01	0.88/-0.35	ns
T <sub>IDOCK/T<sub>OCKD</sub></sub>	D pin setup/hold with respect to CLK without Delay	0.01/0.27	0.01/0.29	0.01/0.33	0.01/0.33	ns
T <sub>IDOCKD/T<sub>OCKDD</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY)	0.02/0.27	0.02/0.29	0.02/0.33	0.01/0.33	ns
<b>Combinatorial</b>						
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.11	0.11	0.13	0.14	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IDELAY)	0.11	0.12	0.14	0.15	ns
<b>Sequential Delays</b>						
T <sub>IDLO</sub>	D pin to Q1 pin using flip-flop as a latch without Delay	0.41	0.44	0.51	0.54	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY)	0.41	0.44	0.51	0.55	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.53	0.57	0.66	0.71	ns
T <sub>RQ_ILOGIC</sub>	SR pin to OQ/TQ out	0.96	1.08	1.32	1.32	ns
T <sub>GSRQ_ILOGIC</sub>	Global set/reset to Q outputs	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
T <sub>RPW_ILOGIC</sub>	Minimum pulse width, SR inputs	0.61	0.72	0.72	0.68	ns, Min

Table 19: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>ODCK/T<sub>OCKD</sub></sub>	D1/D2 pins setup/hold with respect to CLK	0.67/-0.11	0.71/-0.11	0.84/-0.11	0.60/-0.18	ns
T <sub>OOCCK/T<sub>OCKOCE</sub></sub>	OCE pin setup/hold with respect to CLK	0.32/0.58	0.34/0.58	0.51/0.58	0.21/-0.10	ns
T <sub>OSRCK/T<sub>OCKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.37/0.21	0.44/0.21	0.80/0.21	0.62/-0.25	ns
T <sub>OTCK/T<sub>OCKT</sub></sub>	T1/T2 pins setup/hold with respect to CLK	0.69/-0.14	0.73/-0.14	0.89/-0.14	0.60/-0.18	ns
T <sub>TOTCECK/T<sub>OCKTCE</sub></sub>	TCE pin setup/hold with respect to CLK	0.32/0.01	0.34/0.01	0.51/0.01	0.22/-0.10	ns
<b>Combinatorial</b>						
T <sub>ODQ</sub>	D1 to OQ out or T1 to TQ out	0.83	0.96	1.16	1.36	ns
<b>Sequential Delays</b>						
T <sub>OCKQ</sub>	CLK to OQ/TQ out	0.47	0.49	0.56	0.63	ns
T <sub>RQ_OLOGIC</sub>	SR pin to OQ/TQ out	0.72	0.80	0.95	1.12	ns
T <sub>GSRQ_OLOGIC</sub>	Global set/reset to Q outputs	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
T <sub>RPW_OLOGIC</sub>	Minimum pulse width, SR inputs	0.64	0.74	0.74	0.68	ns, Min

## Input Serializer/Deserializer Switching Characteristics

Table 20: ISERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold for Control Lines</b>						
T <sub>ISCCCK_BITSILIP</sub> /T <sub>ISCKC_BITSILIP</sub>	BITSLIP pin setup/hold with respect to CLKDIV	0.01/0.14	0.02/0.15	0.02/0.17	0.02/0.21	ns
T <sub>ISCCCK_CE</sub> / T <sub>ISCKC_CE</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLK (for CE1)	0.45/-0.01	0.50/-0.01	0.72/-0.01	0.35/-0.11	ns
T <sub>ISCCCK_CE2</sub> / T <sub>ISCKC_CE2</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLKDIV (for CE2)	-0.10/0.33	-0.10/0.36	-0.10/0.40	-0.17/0.40	ns
<b>Setup/Hold for Data Lines</b>						
T <sub>ISDCK_D</sub> /T <sub>ISCKD_D</sub>	D pin setup/hold with respect to CLK	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY</sub> /T <sub>ISCKD_DDLY</sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) <sup>(1)</sup>	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.03/0.19	ns
T <sub>ISDCK_D_DDR</sub> /T <sub>ISCKD_D_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY_DDR</sub> /T <sub>ISCKD_DDLY_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode (using IDELAY) <sup>(1)</sup>	0.12/0.12	0.14/0.14	0.17/0.17	0.19/0.19	ns
<b>Sequential Delays</b>						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.53	0.54	0.66	0.67	ns
<b>Propagation Delays</b>						
T <sub>ISDO_DO</sub>	D input to DO output pin	0.11	0.11	0.13	0.14	ns

**Notes:**

1. Recorded at 0 tap value.
2. T<sub>ISCCCK\_CE2</sub> and T<sub>ISCKC\_CE2</sub> are reported as T<sub>ISCCCK\_CE</sub>/T<sub>ISCKC\_CE</sub> in TRACE report.

## Output Serializer/Deserializer Switching Characteristics

Table 21: OSERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
T <sub>OSDCK_D</sub> /T <sub>OSCKD_D</sub>	D input setup/hold with respect to CLKDIV	0.42/0.03	0.45/0.03	0.63/0.03	0.44/-0.25	ns
T <sub>OSDCK_T</sub> /T <sub>OSCKD_T</sub> <sup>(1)</sup>	T input setup/hold with respect to CLK	0.69/-0.13	0.73/-0.13	0.88/-0.13	0.60/-0.25	ns
T <sub>OSDCK_T2</sub> /T <sub>OSCKD_T2</sub> <sup>(1)</sup>	T input setup/hold with respect to CLKDIV	0.31/-0.13	0.34/-0.13	0.39/-0.13	0.46/-0.25	ns
T <sub>oscck_oce</sub> /T <sub>osckc_oce</sub>	OCE input setup/hold with respect to CLK	0.32/0.58	0.34/0.58	0.51/0.58	0.21/-0.15	ns
T <sub>oscck_s</sub>	SR (reset) input setup with respect to CLKDIV	0.47	0.52	0.85	0.70	ns
T <sub>oscck_tce</sub> /T <sub>osckc_tce</sub>	TCE input setup/hold with respect to CLK	0.32/0.01	0.34/0.01	0.51/0.01	0.22/-0.15	ns
<b>Sequential Delays</b>						
T <sub>oscko_oq</sub>	Clock to out from CLK to OQ	0.40	0.42	0.48	0.54	ns
T <sub>oscko_tq</sub>	Clock to out from CLK to TQ	0.47	0.49	0.56	0.63	ns
<b>Combinatorial</b>						
T <sub>osdo_ttq</sub>	T input to TQ Out	0.83	0.92	1.11	1.18	ns

**Notes:**

- T<sub>OSDCK\_T2</sub> and T<sub>OSCKD\_T2</sub> are reported as T<sub>OSDCK\_T</sub>/T<sub>OSCKD\_T</sub> in TRACE report.

Table 23: IO\_FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>IO_FIFO Clock to Out Delays</b>						
T <sub>OFFCKO_DO</sub>	RDCLK to Q outputs	0.55	0.60	0.68	0.81	ns
T <sub>CKO_FLAGS</sub>	Clock to IO_FIFO flags	0.55	0.61	0.77	0.55	ns
<b>Setup/Hold</b>						
T <sub>CCK_D/T<sub>CKC_D</sub></sub>	D inputs to WRCLK	0.47/0.02	0.51/0.02	0.58/0.02	0.76/-0.05	ns
T <sub>IFFCCK_WREN/T<sub>IFFCKC_WREN</sub></sub>	WREN to WRCLK	0.42/-0.01	0.47/-0.01	0.53/-0.01	0.70/-0.05	ns
T <sub>OFFCCK_RDEN/T<sub>OFFCKC_RDEN</sub></sub>	RDEN to RDCLK	0.53/0.02	0.58/0.02	0.66/0.02	0.79/-0.02	ns
<b>Minimum Pulse Width</b>						
T <sub>PWH_IO_FIFO</sub>	RESET, RDCLK, WRCLK	1.62	2.15	2.15	2.15	ns
T <sub>PWL_IO_FIFO</sub>	RESET, RDCLK, WRCLK	1.62	2.15	2.15	2.15	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	RDCLK and WRCLK	266.67	200.00	200.00	200.00	MHz

## CLB Switching Characteristics

Table 24: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
<b>Combinatorial Delays</b>							
T <sub>ILO</sub>	An – Dn LUT address to A	0.10	0.11	0.13	0.15	ns, Max	
T <sub>ILO_2</sub>	An – Dn LUT address to AMUX/CMUX	0.27	0.30	0.36	0.41	ns, Max	
T <sub>ILO_3</sub>	An – Dn LUT address to BMUX_A	0.42	0.46	0.55	0.65	ns, Max	
T <sub>I TO</sub>	An – Dn inputs to A – D Q outputs	0.94	1.05	1.27	1.51	ns, Max	
T <sub>AXA</sub>	AX inputs to AMUX output	0.62	0.69	0.84	1.01	ns, Max	
T <sub>AXB</sub>	AX inputs to BMUX output	0.58	0.66	0.83	0.98	ns, Max	
T <sub>AXC</sub>	AX inputs to CMUX output	0.60	0.68	0.82	0.98	ns, Max	
T <sub>AXD</sub>	AX inputs to DMUX output	0.68	0.75	0.90	1.08	ns, Max	
T <sub>BXB</sub>	BX inputs to BMUX output	0.51	0.57	0.69	0.82	ns, Max	
T <sub>BXD</sub>	BX inputs to DMUX output	0.62	0.69	0.82	0.99	ns, Max	
T <sub>CXC</sub>	CX inputs to CMUX output	0.42	0.48	0.58	0.69	ns, Max	
T <sub>CXD</sub>	CX inputs to DMUX output	0.53	0.59	0.71	0.86	ns, Max	
T <sub>DXD</sub>	DX inputs to DMUX output	0.52	0.58	0.70	0.84	ns, Max	
<b>Sequential Delays</b>							
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.40	0.44	0.53	0.62	ns, Max	
T <sub>SHCKO</sub>	Clock to AMUX – DMUX outputs	0.47	0.53	0.66	0.73	ns, Max	
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>							
T <sub>AS/T<sub>AH</sub></sub>	A <sub>N</sub> – D <sub>N</sub> input to CLK on A – D flip-flops	0.07/0.12	0.09/0.14	0.11/0.18	0.11/0.20	ns, Min	
T <sub>DICK/T<sub>CKDI</sub></sub>	A <sub>X</sub> – D <sub>X</sub> input to CLK on A – D flip-flops	0.06/0.19	0.07/0.21	0.09/0.26	0.09/0.31	ns, Min	
	A <sub>X</sub> – D <sub>X</sub> input through MUXs and/or carry logic to CLK on A – D flip-flops	0.59/0.08	0.66/0.09	0.81/0.11	0.97/0.12	ns, Min	
T <sub>CECK_CLB/</sub> T <sub>CKCE_CLB</sub>	CE input to CLK on A – D flip-flops	0.15/0.00	0.17/0.00	0.21/0.01	0.34/–0.01	ns, Min	
T <sub>SRCK/T<sub>CKSR</sub></sub>	SR input to CLK on A – D flip-flops	0.38/0.03	0.43/0.04	0.53/0.05	0.62/0.05	ns, Min	
<b>Set/Reset</b>							
T <sub>SRMIN</sub>	SR input minimum pulse width	0.52	0.78	1.04	0.95	ns, Min	
T <sub>RQ</sub>	Delay from SR input to AQ – DQ flip-flops	0.53	0.59	0.71	0.83	ns, Max	
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.52	0.58	0.70	0.83	ns, Max	
F <sub>TOG</sub>	Toggle frequency (for export control)	1412	1286	1098	1098	MHz	

## Block RAM and FIFO Switching Characteristics

Table 27: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.85	2.13	2.46	2.87	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.64	0.74	0.89	1.02	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.77	3.04	3.84	5.30	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.73	0.81	0.94	1.11	ns, Max
T <sub>RCKO_DO_CASCOUP</sub> and T <sub>RCKO_DO_CASCOUP_REG</sub>	Clock CLK to DOUT output with cascade (without output register) <sup>(2)</sup>	2.61	2.88	3.30	3.76	ns, Max
	Clock CLK to DOUT output with cascade (with output register) <sup>(4)</sup>	1.16	1.28	1.46	1.56	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.76	0.87	1.05	1.14	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.94	1.02	1.15	1.30	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.78	0.85	0.94	1.10	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.56	2.81	3.55	4.90	ns, Max
	Clock CLK to BITERR (with output register)	0.68	0.76	0.89	1.05	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.75	0.88	1.07	1.15	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.84	0.93	1.08	1.29	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.45/0.31	0.49/0.33	0.57/0.36	0.77/0.45	ns, Min
T <sub>RDCK_DI_WF_NC</sub> /T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.58/0.60	0.65/0.63	0.74/0.67	0.92/0.76	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.20/0.29	0.22/0.34	0.25/0.41	0.29/0.38	ns, Min
T <sub>RDCK_DI_ECC</sub> /T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.50/0.43	0.55/0.46	0.63/0.50	0.78/0.54	ns, Min
T <sub>RDCK_DI_ECCW</sub> /T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.93/0.43	1.02/0.46	1.17/0.50	1.38/0.48	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> /T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	1.04/0.56	1.15/0.59	1.32/0.64	1.55/0.77	ns, Min
T <sub>RCKC_INJECTBITERR</sub> /T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.58/0.35	0.64/0.37	0.74/0.40	0.92/0.48	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM enable (EN) input	0.35/0.20	0.39/0.21	0.45/0.23	0.57/0.26	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.24/0.15	0.29/0.15	0.36/0.16	0.40/0.19	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.29/0.07	0.32/0.07	0.35/0.07	0.41/0.07	ns, Min

Table 27: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>RCKC_RSTRAM</sub> /T <sub>RCKC_RSTRAM</sub>	Synchronous RSTRAM input	0.32/0.42	0.34/0.43	0.36/0.46	0.40/0.47	ns, Min
T <sub>RCKC_WEA</sub> /T <sub>RCKC_WEA</sub>	Write enable (WE) input (block RAM only)	0.44/0.18	0.48/0.19	0.54/0.20	0.64/0.23	ns, Min
T <sub>RCKC_WREN</sub> /T <sub>RCKC_WREN</sub>	WREN FIFO inputs	0.46/0.30	0.46/0.35	0.47/0.43	0.77/0.44	ns, Min
T <sub>RCKC_RDEN</sub> /T <sub>RCKC_RDEN</sub>	RDEN FIFO inputs	0.42/0.30	0.43/0.35	0.43/0.43	0.71/0.44	ns, Min
<b>Reset Delays</b>						
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO flags/pointers <sup>(10)</sup>	0.90	0.98	1.10	1.25	ns, Max
T <sub>RREC_RST</sub> /T <sub>RREM_RST</sub>	FIFO reset recovery and removal timing <sup>(11)</sup>	1.87/-0.81	2.07/-0.81	2.37/-0.81	2.44/-0.71	ns, Max
<b>Maximum Frequency</b>						
F <sub>MAX_BRAM_WF_NC</sub>	Block RAM (write first and no change modes) when not in SDP RF mode	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_BRAM_RF_PERFORMANCE</sub>	Block RAM (read first, performance mode) when in SDP RF mode but no address overlap between port A and port B	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_BRAM_RF_DELAYED_WRITE</sub>	Block RAM (read first, delayed write mode) when in SDP RF mode and there is possibility of overlap between port A and port B addresses	447.63	404.53	339.67	268.96	MHz
F <sub>MAX_CAS_WF_NC</sub>	Block RAM cascade (write first, no change mode) when cascade but not in RF mode	467.07	418.59	345.78	273.30	MHz
F <sub>MAX_CAS_RF_PERFORMANCE</sub>	Block RAM cascade (read first, performance mode) when in cascade with RF mode and no possibility of address overlap/one port is disabled	467.07	418.59	345.78	273.30	MHz
F <sub>MAX_CAS_RF_DELAYED_WRITE</sub>	When in cascade RF mode and there is a possibility of address overlap between port A and port B	405.35	362.19	297.35	226.60	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes without ECC	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	410.34	365.10	297.53	215.38	MHz

**Notes:**

1. TRACE will report all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. These parameters include both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).

Table 28: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_MREG</sub>	CLK MREG to P output	1.68	1.93	2.31	2.73	ns
T <sub>DSPCKO_CARRYCASCOU_MREG</sub>	CLK MREG to CARRYCASCOU output	1.92	2.21	2.64	3.12	ns
T <sub>DSPCKO_P_ADREG_MULT</sub>	CLK ADREG to P output using multiplier	2.72	3.10	3.69	4.60	ns
T <sub>DSPCKO_CARRYCASCOU_ADREG_MULT</sub>	CLK ADREG to CARRYCASCOU output using multiplier	2.96	3.38	4.02	4.99	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_AREG_MULT</sub>	CLK AREG to P output using multiplier	3.94	4.51	5.37	6.84	ns
T <sub>DSPCKO_P_BREG</sub>	CLK BREG to P output not using multiplier	1.64	1.87	2.22	2.65	ns
T <sub>DSPCKO_P_CREG</sub>	CLK CREG to P output not using multiplier	1.69	1.93	2.30	2.81	ns
T <sub>DSPCKO_P_DREG_MULT</sub>	CLK DREG to P output using multiplier	3.91	4.48	5.32	6.77	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
T <sub>DSPCKO_{ACOUT; BCOUT}_{AREG; BREG}</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.64	0.73	0.87	1.02	ns
T <sub>DSPCKO_CARRYCASCOU_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	4.19	4.79	5.70	7.24	ns
T <sub>DSPCKO_CARRYCASCOU_BREG</sub>	CLK BREG to CARRYCASCOU output not using multiplier	1.88	2.15	2.55	3.04	ns
T <sub>DSPCKO_CARRYCASCOU_DREG_MULT</sub>	CLK DREG to CARRYCASCOU output using multiplier	4.16	4.76	5.65	7.17	ns
T <sub>DSPCKO_CARRYCASCOU_CREG</sub>	CLK CREG to CARRYCASCOU output	1.94	2.21	2.63	3.20	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	With all registers used	628.93	550.66	464.25	363.77	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	531.63	465.77	392.93	310.08	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	349.28	305.62	257.47	210.44	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	317.26	277.62	233.92	191.28	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	260.01	227.01	190.69	150.13	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	241.72	211.15	177.43	140.10	MHz

Table 34: MMCM Specification (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
MMCM_F_BANDWIDTH	Low MMCM bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High MMCM bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
MMCM_T_STATPHAOFFSET	Static phase offset of the MMCM outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
MMCM_T_OUTJITTER	MMCM output jitter	Note 3				
MMCM_T_OUTDUTY	MMCM output clock duty-cycle precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
MMCM_T_LOCKMAX	MMCM maximum lock time	100.00	100.00	100.00	100.00	μs
MMCM_F_OUTMAX	MMCM maximum output frequency	800.00	800.00	800.00	800.00	MHz
MMCM_F_OUTMIN	MMCM minimum output frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	4.69	MHz
MMCM_T_EXTFDVAR	External clock feedback variation	< 20% of clock input period or 1 ns Max				
MMCM_RST_MINPULSE	Minimum reset pulse width	5.00	5.00	5.00	5.00	ns
MMCM_F_PFDMAX	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	450.00	MHz
MMCM_F_PFDMIN	Minimum frequency at the phase frequency detector	10.00	10.00	10.00	10.00	MHz
MMCM_T_FBDelay	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle				
<b>MMCM Switching Characteristics Setup and Hold</b>						
T_MMCM_DCK_PSEN/ T_MMCM_CKD_PSEN	Setup and hold of phase-shift enable	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T_MMCM_DCK_PSINCDEC/ T_MMCM_CKD_PSINCDEC	Setup and hold of phase-shift increment/decrement	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T_MMCM_CKO_PSDONE	Phase shift clock-to-out of PSDONE	0.59	0.68	0.81	0.78	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>						
T_MMCM_DCK_DADDR/ T_MMCM_CKD_DADDR	DADDR setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_DCK_DI/ T_MMCM_CKD_DI	DI setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_DCK_DEN/ T_MMCM_CKD_DEN	DEN setup/hold	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T_MMCM_DCK_DWE/ T_MMCM_CKD_DWE	DWE setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T_MMCM_CKO_DRDY	CLK to out of DRDY	0.65	0.72	0.99	0.70	ns, Max
F_DCK	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

**Notes:**

- The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
- The static offset is measured between any MMCM outputs with identical phase.
- Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
- Includes global clock buffer.
- Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
- When CLKOUT4\_CASCADE = TRUE, MMCM\_F\_OUTMIN is 0.036 MHz.

## PLL Switching Characteristics

Table 35: PLL Specification

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
PLL_F <sub>INMAX</sub>	Maximum input clock frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>INMIN</sub>	Minimum input clock frequency	19.00	19.00	19.00	19.00	MHz
PLL_F <sub>INJITTER</sub>	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max				
PLL_F <sub>INDUTY</sub>	Allowable input duty cycle: 19—49 MHz	25	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	45	%
PLL_F <sub>VCOMIN</sub>	Minimum PLL VCO frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>VCOMAX</sub>	Maximum PLL VCO frequency	2133.00	1866.00	1600.00	1600.00	MHz
PLL_F <sub>BANDWIDTH</sub>	Low PLL bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High PLL bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
PLL_T <sub>STATPHAOFFSET</sub>	Static phase offset of the PLL outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
PLL_T <sub>OUTJITTER</sub>	PLL output jitter	Note 3				
PLL_T <sub>OUTDUTY</sub>	PLL output clock duty-cycle precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
PLL_T <sub>LOCKMAX</sub>	PLL maximum lock time	100.00	100.00	100.00	100.00	μs
PLL_F <sub>OUTMAX</sub>	PLL maximum output frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>OUTMIN</sub>	PLL minimum output frequency <sup>(5)</sup>	6.25	6.25	6.25	6.25	MHz
PLL_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max				
PLL_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	5.00	ns
PLL_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	450.00	MHz
PLL_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	19.00	19.00	19.00	19.00	MHz
PLL_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle				

### Dynamic Reconfiguration Port (DRP) for PLL Before and After DCLK

T <sub>PLLDCK_DADDR</sub> /T <sub>PLLCKD_DADDR</sub>	Setup and hold of D address	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DI</sub> /T <sub>PLLCKD_DI</sub>	Setup and hold of D input	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DEN</sub> /T <sub>PLLCKD_DEN</sub>	Setup and hold of D enable	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T <sub>PLLDCK_DWE</sub> /T <sub>PLLCKD_DWE</sub>	Setup and hold of D write enable	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

#### Notes:

1. The PLL does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any PLL outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as F<sub>VCO</sub>/128 assuming output duty cycle is 50%.

Table 39: Clock-Capable Clock Input to Output Delay With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with</i> PLL.							
TICKOFPPLLCC	Clock-capable clock input and OUTFF <i>with</i> PLL	XC7A100T	0.70	0.70	0.70	1.41	ns
		XC7A200T	0.69	0.69	0.69	1.47	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is already included in the timing calculation.

Table 40: Pin-to-Pin, Clock-to-Out using BUFI0

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, with BUFI0.						
TICKOFC0	Clock to out of I/O clock	5.01	5.61	6.64	7.34	ns

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 41: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Full delay (legacy delay or default delay) global clock input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O banks	XC7A100T	2.69/-0.46	2.89/-0.46	3.34/-0.46	5.66/-0.52	ns	
		XC7A200T	3.03/-0.50	3.27/-0.50	3.79/-0.50	6.66/-0.53	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. A zero "0" hold time listing indicates no hold time or a negative hold time.

**Table 42: Clock-Capable Clock Input Setup and Hold With MMCM**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSMMCMCC</sub> / T <sub>PHMMCMCC</sub>	No delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7A100T	2.44/-0.62	2.80/-0.62	3.36/-0.62	2.15/-0.49	ns	
		XC7A200T	2.57/-0.63	2.94/-0.63	3.52/-0.63	2.32/-0.53	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

**Table 43: Clock-Capable Clock Input Setup and Hold With PLL**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
T <sub>PSPLLCC</sub> / T <sub>PHPLLCC</sub>	No delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7A100T	2.78/-0.32	3.15/-0.32	3.78/-0.32	2.47/-0.60	ns	
		XC7A200T	2.91/-0.33	3.29/-0.33	3.94/-0.33	2.64/-0.63	ns	

**Notes:**

1. Setup and hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the global clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the global clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input flip-flop or latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

**Table 48** summarizes the DC specifications of the clock input of the GTP transceiver. Consult [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) for further details.

**Table 48: GTP Transceiver Clock DC Input Level Specification**

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	350	—	2000	mV
R <sub>IN</sub>	Differential input resistance	—	100	—	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	—	100	—	nF

## GTP Transceiver Switching Characteristics

Consult [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) for further information.

**Table 49: GTP Transceiver Performance**

Symbol	Description	Output Divider	Speed Grade								Units	
			1.0V				0.9V					
			-3		-2/-2L		-1		-2L			
			Package Type									
			FFG FBG SBG	FGG FTG CSG	FFG FBG SBG	FGG FTG CSG	FFG FBG SBG	FGG FTG CSG	FFG FBG SBG	FGG FTG CSG		
F <sub>GTPMAX</sub>	Maximum GTP transceiver data rate		6.6	5.4	6.6	5.4	3.75	3.75	3.75	3.75	Gb/s	
F <sub>GTPMIN</sub>	Minimum GTP transceiver data rate		0.500	0.500	0.500	0.500	0.500	0.500	0.500	0.500	Gb/s	
F <sub>GTPRANGE</sub>	PLL line rate range	1	3.2–6.6		3.2–6.6		3.2–3.75		3.2–3.75		Gb/s	
		2	1.6–3.3		1.6–3.3		1.6–3.2		1.6–3.2		Gb/s	
		4	0.8–1.65		0.8–1.65		0.8–1.6		0.8–1.6		Gb/s	
		8	0.5–0.825		0.5–0.825		0.5–0.8		0.5–0.8		Gb/s	
F <sub>GTPPLL RANGE</sub>	GTP transceiver PLL frequency range		1.6–3.3		1.6–3.3		1.6–3.3		1.6–3.3		GHz	

**Table 50: GTP Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics**

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
F <sub>GTPDRPCLK</sub>	GTPDRPCLK maximum frequency	175	175	156	125	MHz	

**Table 51: GTP Transceiver Reference Clock Switching Characteristics**

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
F <sub>GCLK</sub>	Reference clock frequency range		60	—	660	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%	—	200	—	ps
T <sub>FCLK</sub>	Reference clock fall time	20% – 80%	—	200	—	ps
T <sub>DCREF</sub>	Reference clock duty cycle	Transceiver PLL only	40	—	60	%

Table 63: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Internal Configuration Access Port</b>						
F <sub>ICAPCK</sub>	Internal configuration access port (ICAPE2) clock frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Master/Slave Serial Mode Programming Switching</b>						
T <sub>DCCCK/T<sub>CCKD</sub></sub>	DIN setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>CCO</sub>	DOUT clock to out	8.00	8.00	8.00	9.00	ns, Max
<b>SelectMAP Mode Programming Switching</b>						
T <sub>SMDCCK/T<sub>SMCCKD</sub></sub>	D[31:00] setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
T <sub>SMCSCCK/T<sub>SMCCKCS</sub></sub>	CSI_B setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>SMWCCK/T<sub>SMCCKW</sub></sub>	RDWR_B setup/hold	10.00/0.00	10.00/0.00	10.00/0.00	12.00/0.00	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out (330 Ω pull-up resistor required)	7.00	7.00	7.00	8.00	ns, Max
T <sub>SMCO</sub>	D[31:00] clock to out in readback	8.00	8.00	8.00	10.00	ns, Max
F <sub>RBCCK</sub>	Readback frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
T <sub>TAPTCK/T<sub>TCKTAP</sub></sub>	TMS and TDI setup/hold	3.00/2.00	3.00/2.00	3.00/2.00	3.00/2.00	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output	7.00	7.00	7.00	8.50	ns, Max
F <sub>TCK</sub>	TCK frequency	66.00	66.00	66.00	50.00	MHz, Max
<b>BPI Flash Master Mode Programming Switching</b>						
T <sub>BPICCO<sup>(2)</sup></sub>	A[28:00], RS[1:0], FCS_B, FOE_B, FWE_B, ADV_B clock to out	8.50	8.50	8.50	10.00	ns, Max
T <sub>BPIDCC/T<sub>BPICCD</sub></sub>	D[15:00] setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
<b>SPI Flash Master Mode Programming Switching</b>						
T <sub>SPIDCC/T<sub>SPICCD</sub></sub>	D[03:00] setup/hold	3.00/0.00	3.00/0.00	3.00/0.00	3.00/0.00	ns, Min
T <sub>SPICCM</sub>	MOSI clock to out	8.00	8.00	8.00	9.00	ns, Max
T <sub>SPICCFC</sub>	FCS_B clock to out	8.00	8.00	8.00	9.00	ns, Max

**Notes:**

1. To support longer delays in configuration, use the design solutions described in [UG470: 7 Series FPGA Configuration User Guide](#).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.

## eFUSE Programming Conditions

Table 64 lists the programming conditions specifically for eFUSE. For more information, see [UG470: 7 Series FPGA Configuration User Guide](#).

Table 64: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
I <sub>FS</sub>	V <sub>CCAUX</sub> supply current	–	–	115	mA
t <sub>j</sub>	Temperature range	15	–	125	°C

**Notes:**

1. The FPGA must not be configured during eFUSE programming.

## Revision History

The following table shows the revision history for this document:

Date	Version	Description
09/26/11	1.0	Initial Xilinx release.
11/07/11	1.1	Revised the $V_{OCM}$ specification in <a href="#">Table 11</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.3 software v1.02 speed specification throughout document including <a href="#">Table 12</a> and <a href="#">Table 13</a> . Added $MMCM\_T_{FBDELAY}$ while adding $MMCM\_$ to the symbol names of a few specifications in <a href="#">Table 34</a> and PLL to the symbol names in <a href="#">Table 35</a> . In <a href="#">Table 36</a> through <a href="#">Table 43</a> , updated the pin-to-pin description with the SSTL15 standard. Updated units in <a href="#">Table 46</a> .
02/13/12	1.2	Updated the Artix-7 family of devices listed throughout the entire data sheet. Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.4 software v1.03 for the -3, -2, and -1 speed grades and v1.00 for the -2L speed grade. Updated summary description on <a href="#">page 1</a> . In <a href="#">Table 2</a> , revised $V_{CCO}$ for the 3.3V HR I/O banks and updated $T_j$ . Updated the notes in <a href="#">Table 5</a> . Added MGTAVCC and MGTAVTT power supply ramp times to <a href="#">Table 7</a> . Rearranged <a href="#">Table 8</a> , added Mobile_DDR, HSTL_I_18, HSTL_II_18, HSUL_12, SSTL135_R, SSTL15_R, and SSTL12 and removed DIFF_SSTL135, DIFF_SSTL18_I, DIFF_SSTL18_II, DIFF_HSTL_I, and DIFF_HSTL_II. Added <a href="#">Table 9</a> and <a href="#">Table 10</a> . Revised the specifications in <a href="#">Table 11</a> . Revised $V_{IN}$ in <a href="#">Table 47</a> . Updated the <a href="#">eFUSE Programming Conditions</a> section and removed the endurance table. Added the <a href="#">table</a> . Revised $F_{TXIN}$ and $F_{RXIN}$ in <a href="#">Table 53</a> . Revised $I_{CCADC}$ and updated <a href="#">Note 1</a> in <a href="#">Table 62</a> . Revised DDR LVDS transmitter data width in <a href="#">Table 14</a> . Removed notes from <a href="#">Table 24</a> as they are no longer applicable. Updated specifications in <a href="#">Table 63</a> . Updated <a href="#">Note 1</a> in <a href="#">Table 33</a> .
06/01/12	1.3	Reorganized entire data sheet including adding <a href="#">Table 40</a> and <a href="#">Table 44</a> . Updated $T_{SOL}$ in <a href="#">Table 1</a> . Updated $I_{BATT}$ and added $R_{IN\_TERM}$ to <a href="#">Table 3</a> . Updated <a href="#">Power-On/Off Power Supply Sequencing</a> section with regards to GTP transceivers. In <a href="#">Table 8</a> , updated many parameters including SSTL135 and SSTL135_R. Removed $V_{OX}$ column and added DIFF_HSUL_12 to <a href="#">Table 10</a> . Updated $V_{OL}$ in <a href="#">Table 11</a> . Updated <a href="#">Table 14</a> and removed notes 2 and 3. Updated <a href="#">Table 15</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 14.1 software v1.03 for the -3, -2, -2L (1.0V), -1, and v1.01 for the -2L (0.9V) speed specifications throughout the document. In <a href="#">Table 27</a> , updated <a href="#">Reset Delays</a> section including <a href="#">Note 10</a> and <a href="#">Note 11</a> . In <a href="#">Table 53</a> , replaced $F_{TXOUT}$ with $F_{GLK}$ . Updated many of the XADC specifications in <a href="#">Table 62</a> and added <a href="#">Note 2</a> . Updated and moved <i>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</i> section from <a href="#">Table 63</a> to <a href="#">Table 34</a> and <a href="#">Table 35</a> .